 Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/789,295	WANG ET AL.	
Examiner	Art Unit	
Mark Kopec	1751	

	SEAR	CHED	
Class	Subclass	Date	Examiner
252	511	9/11/2006	M.K.
423	445R		
977	779		
977	785	7	1

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SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
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